

Search Notes

Application No.

10/647,905

Examiner

Sin J. Lee

Applicant(s)

NOGLIK ET AL.

Art Unit

1752

SEARCHED

Class	Subclass	Date	Examiner
430	213.1	9-19 -04	SJL
	211.1		
	210.1		
	302		
	906,910		
	908,944		
	945,286.1		
	287.1, 280.1		
✓	284.1	✓	✓

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner